

-50V P-Channel Enhancement Mode MOSFET

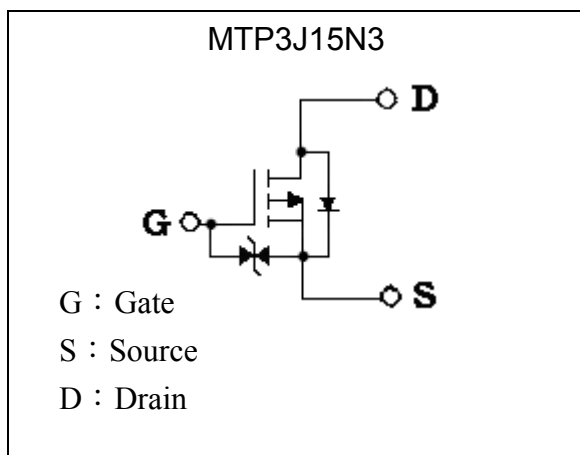
MTP3J15N3

BV _{DSS}	-50V
I _D @V _{GS} =-5V, T _A =25°C	-130mA
R _{DS(on)} @V _{GS} =-10V, I _D =-100mA	5Ω (typ)
R _{DS(on)} @V _{GS} =-5V, I _D =-100mA	6Ω (typ)

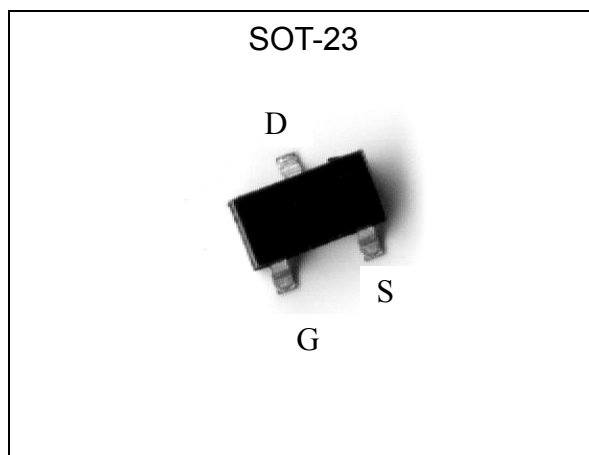
Features

- Low gate charge
- Excellent thermal and electrical capabilities
- Pb-free lead plating and halogen-free package

Equivalent Circuit

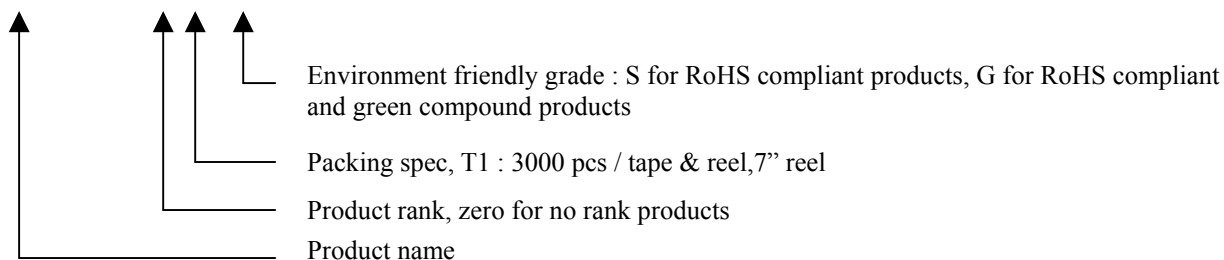


Outline



Ordering Information

Device	Package	Shipping
MTP3J15N3-0-T1-G	SOT-23 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





Absolute Maximum Ratings (Tj=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	-50	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current @ T _A =25°C, V _{GS} =-5V	I _D	-130	mA
Pulsed Drain Current (Note 1)	I _{DM}	-520	
Maximum Power Dissipation @ T _A =25°C	P _D	225	mW
Thermal Resistance, Junction-to-Ambient	R _{th,ja}	556	°C/W
Maximum Lead Temperature for Soldering Purpose, 10 s	T _L	260	°C
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	

Note : 1. Pulse width ≤ 10μs, duty cycle ≤ 2%.

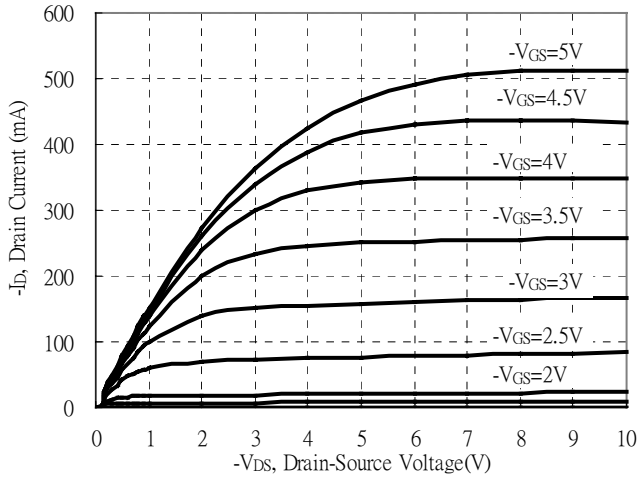
Electrical Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-50	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-1	-1.4	-2		V _{DS} =V _{GS} , I _D =-1mA
G _{FS}	100	-	-	mS	V _{DS} =-15V, I _D =-100mA
I _{GSS}	-	-	±10	μA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	-0.1	μA	V _{DS} =-25V, V _{GS} =0V
	-	-	-1		V _{DS} =-50V, V _{GS} =0V
	-	-	-25		V _{DS} =-50V, V _{GS} =0V, T _j =125°C
*R _{DS(ON)}	-	6	10	Ω	V _{GS} =-5V, I _D =-100mA
	-	5	8		V _{GS} =-10V, I _D =-100mA
Dynamic					
C _{iss}	-	25	-	pF	V _{DS} =-5V, V _{GS} =0V, f=1MHz
C _{oss}	-	7	-		
C _{rss}	-	2	-		
*t _{d(ON)}	-	2.5	-	ns	V _{DS} =-15V, I _D =-100mA, V _{GS} =-5V, R _G =3.3Ω
*t _r	-	2	-		
*t _{d(OFF)}	-	7.3	-		
*t _f	-	3	-		
*Q _g	-	1.2	-	nC	V _{DS} =-40V, I _D =-500mA, V _{GS} =-5V
Source-Drain Diode					
*I _S	-	-	-130	mA	
*I _{SM}	-	-	-520		
*V _{SD}	-	-0.85	-1.2	V	V _{GS} =0V, I _S =-130mA

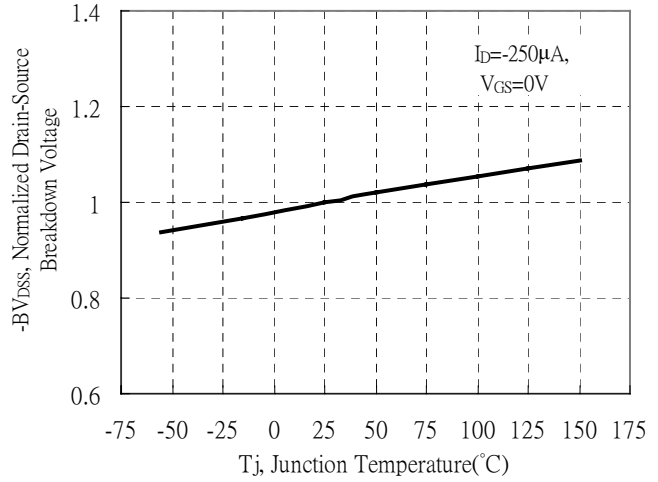
*Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%

Typical Characteristics

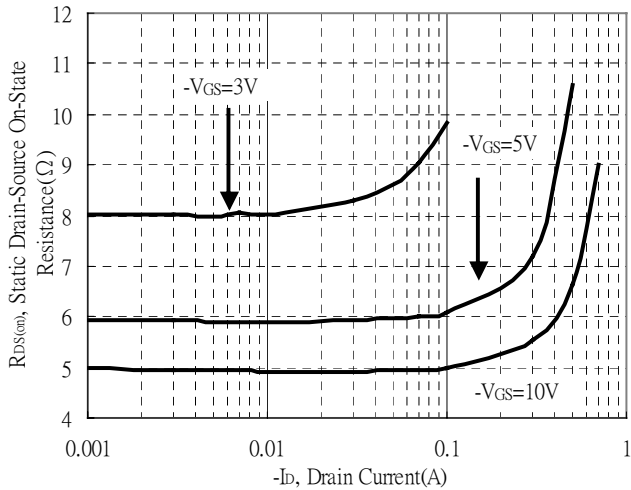
Typical Output Characteristics



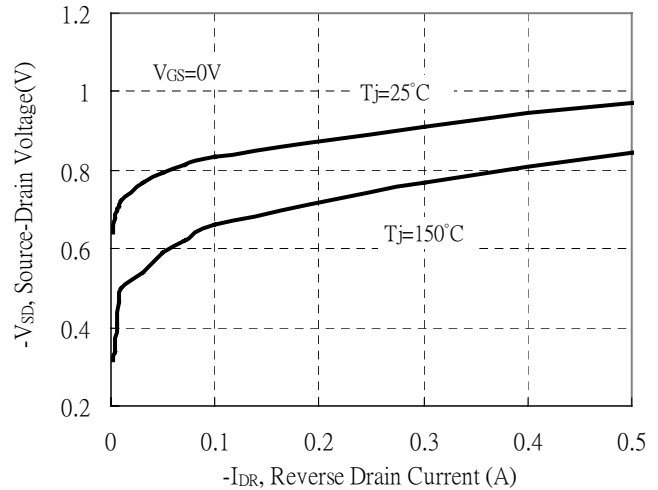
Breakdown Voltage vs Ambient Temperature



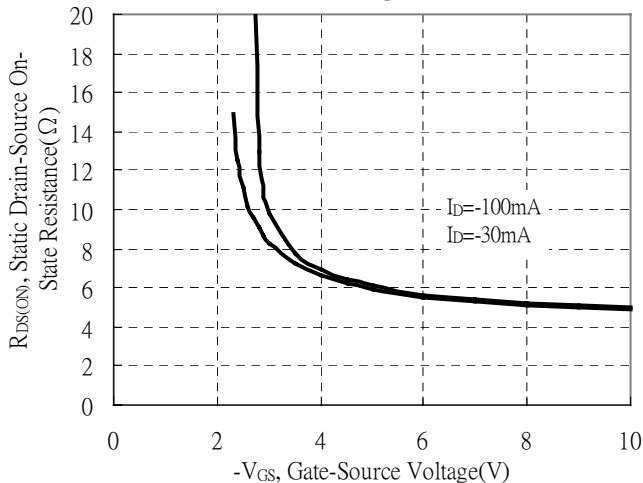
Static Drain-Source On-State resistance vs Drain Current



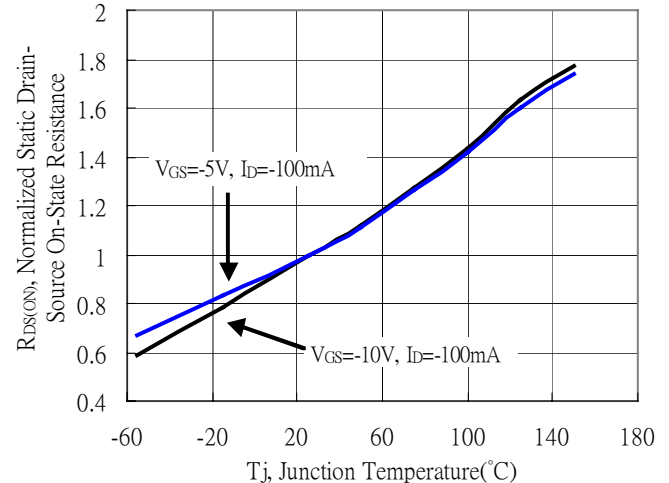
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

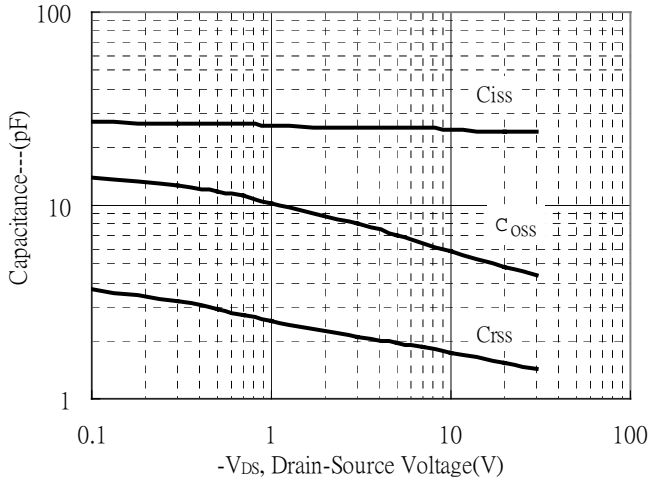


Drain-Source On-State Resistance vs Junction Temperature

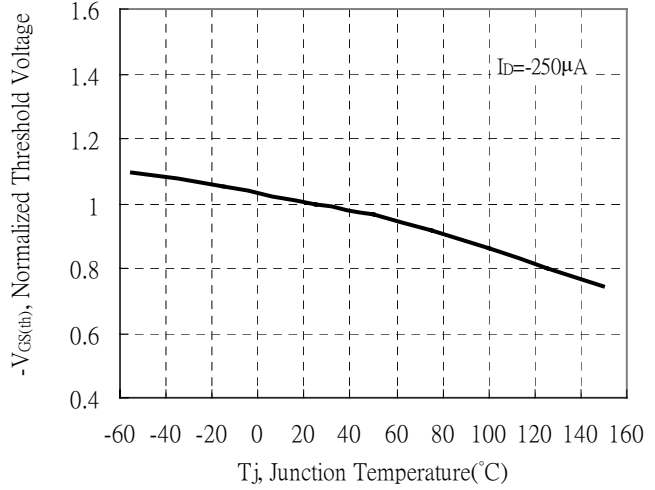


Typical Characteristics(Cont.)

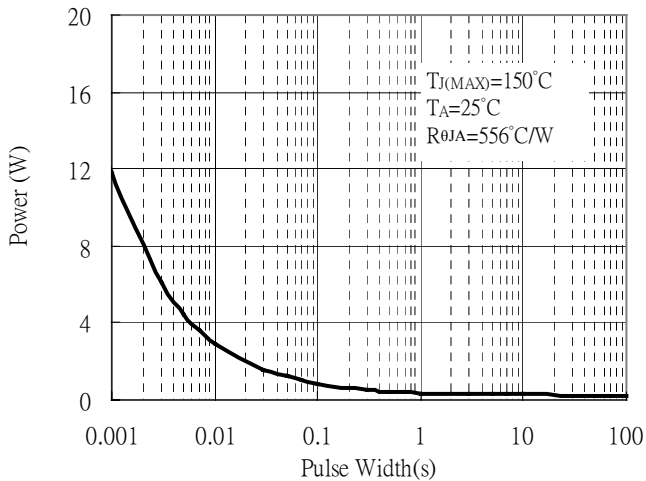
Capacitance vs Drain-to-Source Voltage



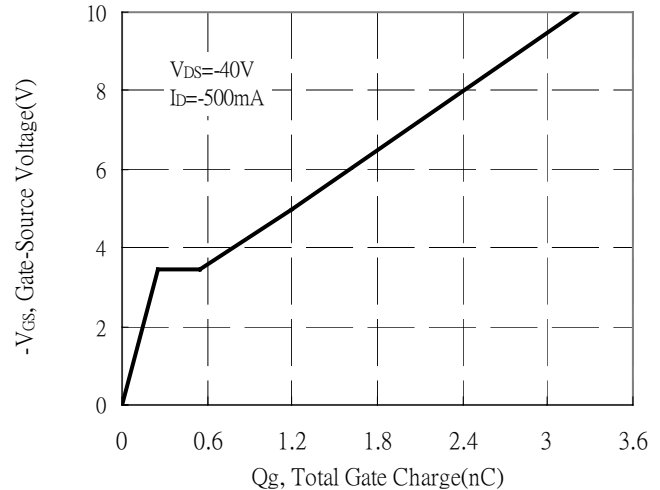
Threshold Voltage vs Junction Temperature



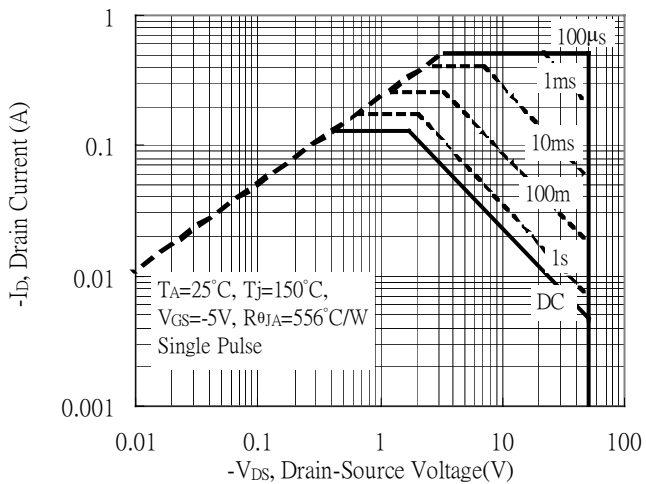
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



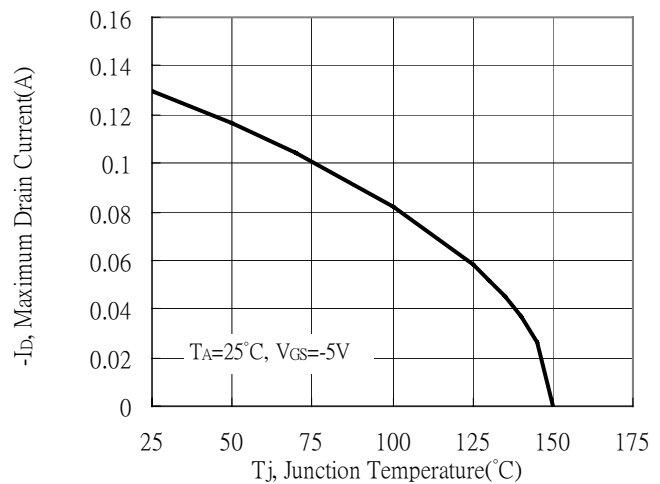
Gate Charge Characteristics



Maximum Safe Operating Area

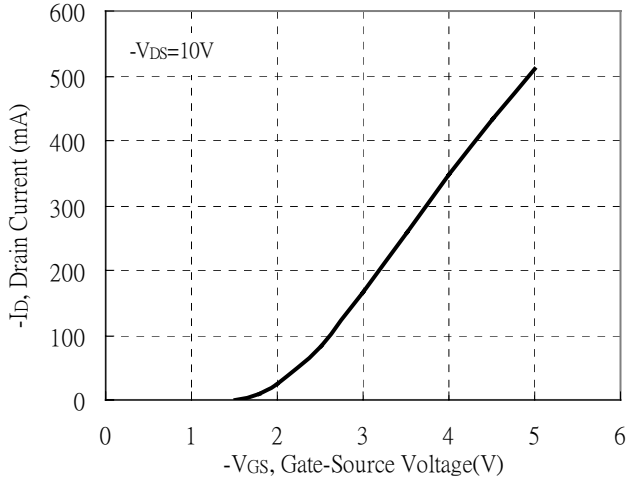


Maximum Drain Current vs Junction Temperature

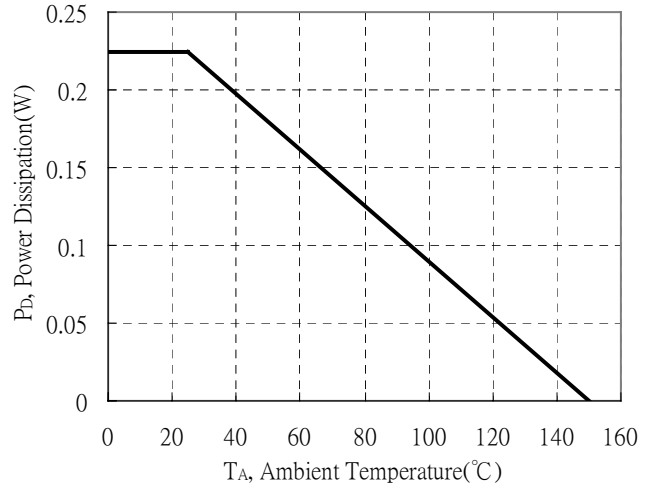


Typical Characteristics(Cont.)

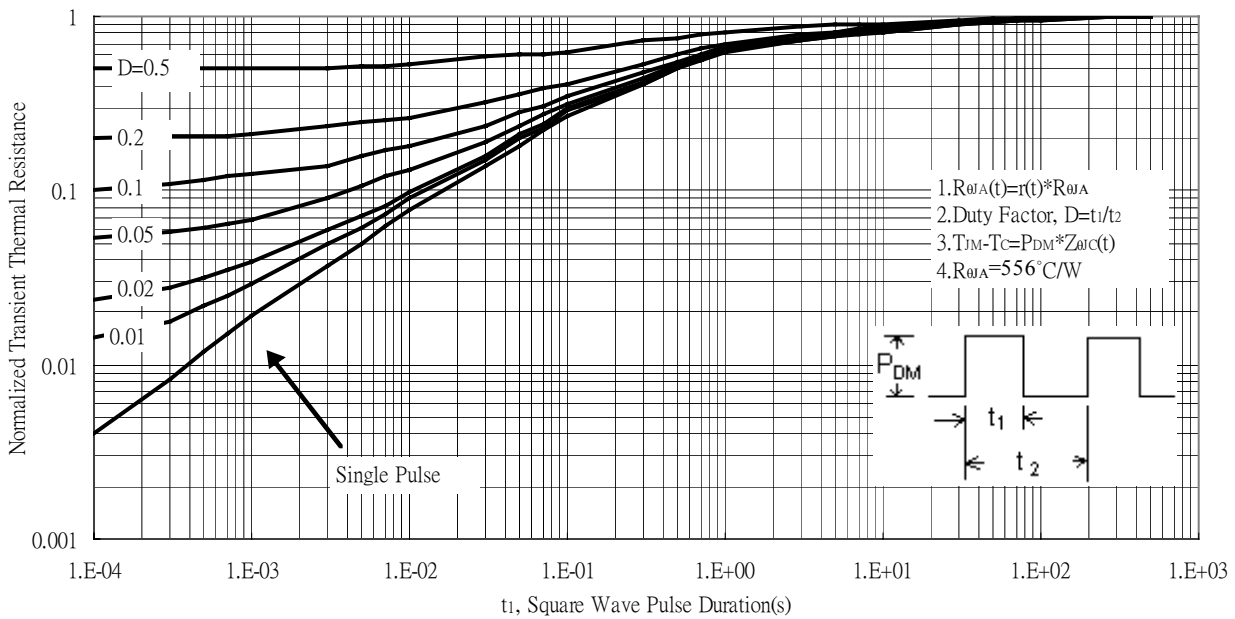
Typical Transfer Characteristics



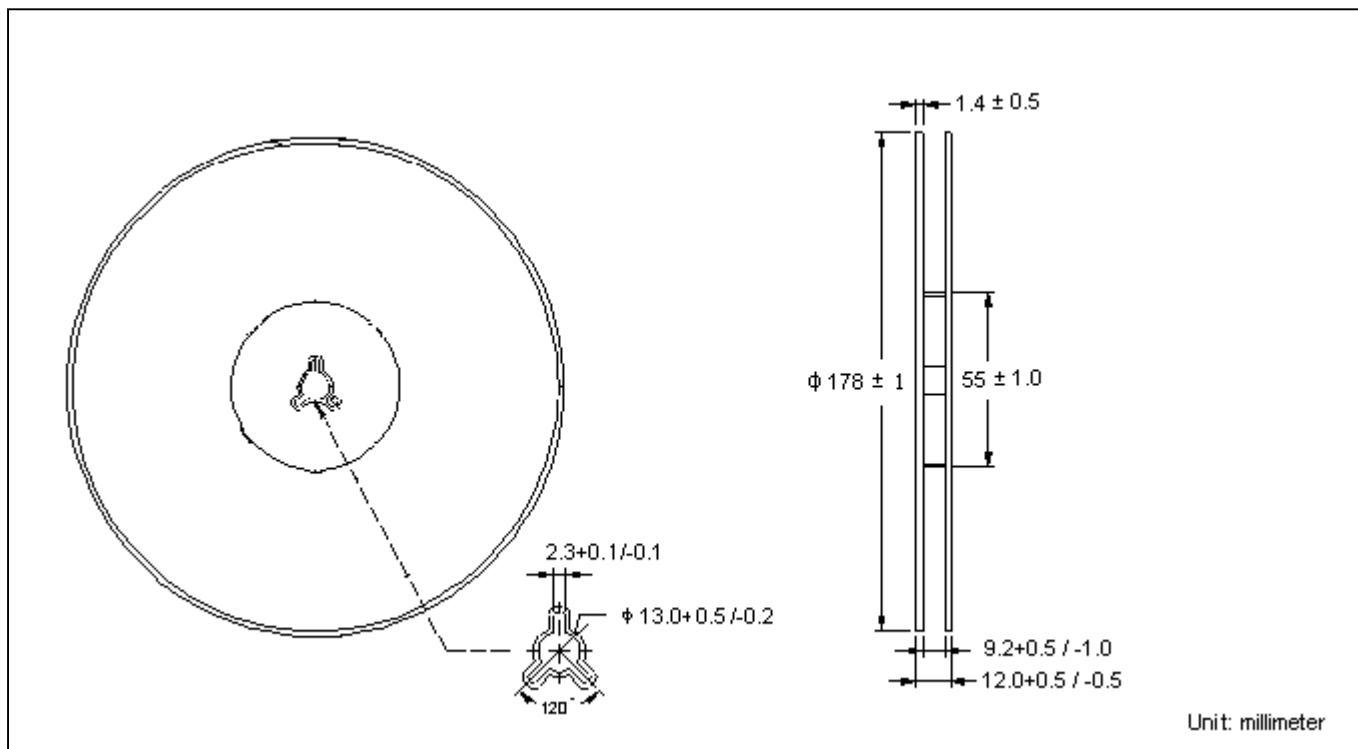
Power Derating Curve



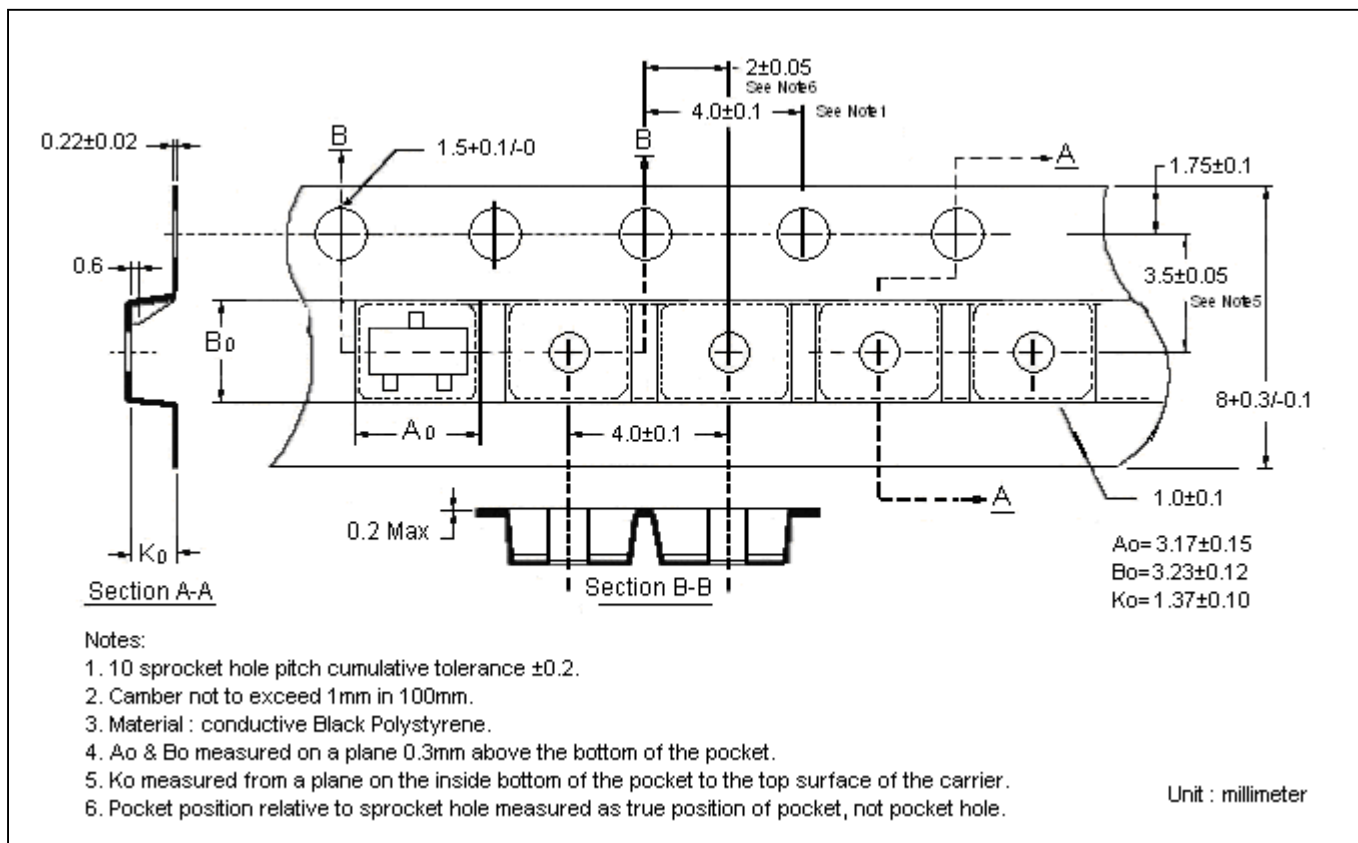
Transient Thermal Response Curves



Reel Dimension



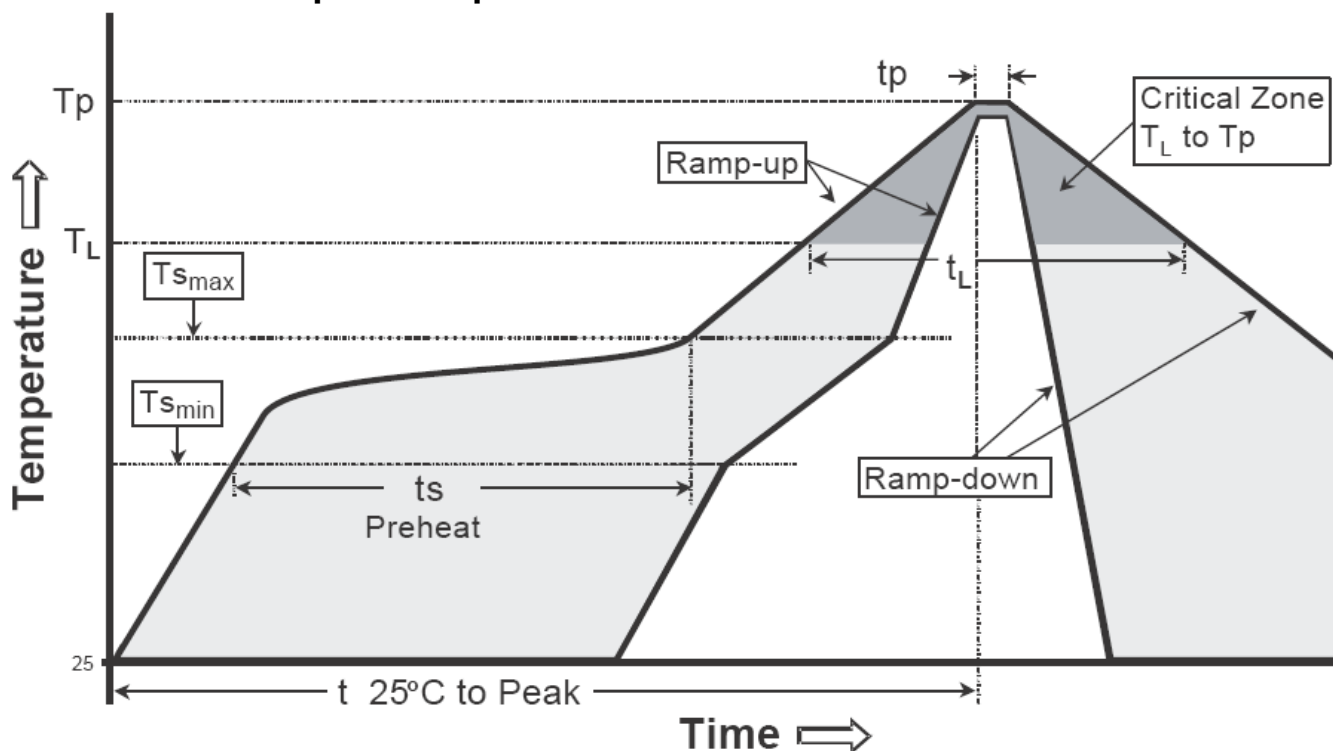
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

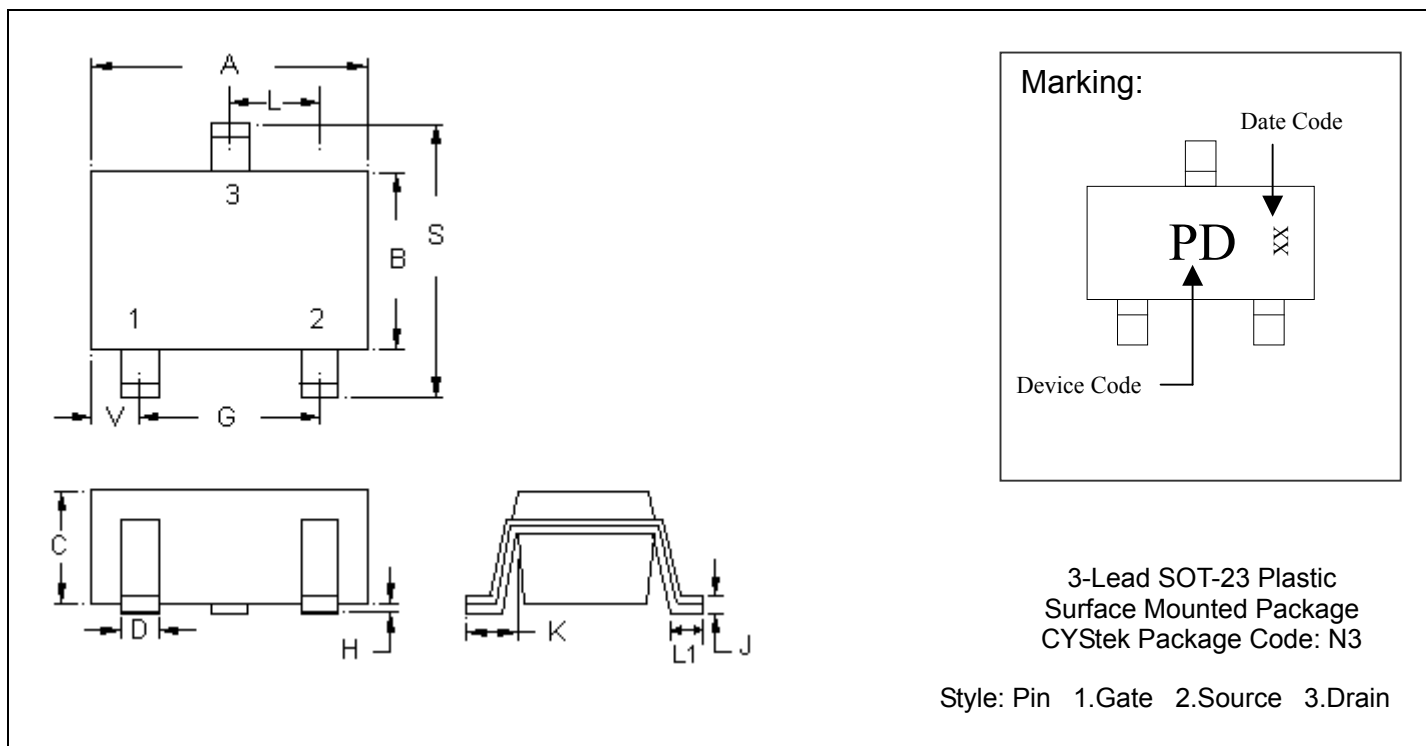
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-23 Dimension



*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0032	0.0079	0.08	0.20
B	0.0472	0.0669	1.20	1.70	K	0.0118	0.0266	0.30	0.67
C	0.0335	0.0512	0.89	1.30	L	0.0335	0.0453	0.85	1.15
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1161	2.10	2.95
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0000	0.0040	0.00	0.10	L1	0.0118	0.0197	0.30	0.50

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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